

Search Notes**Application/Control No.**

10/660,950

Examiner

Maikhanh Nguyen

**Applicant(s)/Patent under
Reexamination**

O'DONNELL, SHAWN

Art Unit

2176

SEARCHED

| Class | Subclass | Date | Examiner |
|---------|----------|------------|----------|
| 715 | 505 | 10/22/2005 | MK |
| 715 | 506,507 | 10/22/2005 | MK |
| 707 | 10 | 10/22/2005 | MK |
| Updated | above | 5/16/2006 | MK |
| Updated | above | 2/19/2007 | MK |
| Updated | above | 1/18/2008 | MK |
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INTERFERENCE SEARCHED

| Class | Subclass | Date | Examiner |
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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

| | DATE | EXMR |
|--|------------|------|
| Inventor Name Search | 10/22/2005 | MK |
| West Search | 10/22/2005 | MK |
| NPL (IEEE) | 10/22/2005 | MK |
| West Updated (USPAT, US-PGPUB, EPO, JPO, DERWENT, IBM_TDB) See Search History Printout | 5/16/2006 | MK |
| West Updated (USPAT, US-PGPUB, EPO, JPO, DERWENT, IBM_TDB) See Search History Printout | 2/19/2007 | MK |
| West Updated (USPAT, US-PGPUB, EPO, JPO, DERWENT, IBM_TDB) See Search History Printout | 1/18/2008 | MK |
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